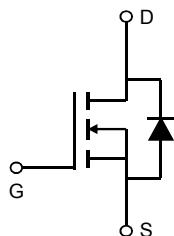
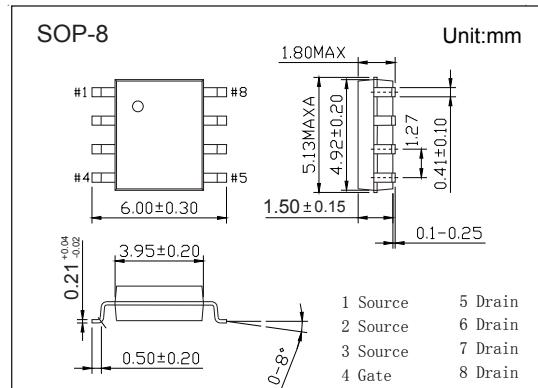


## N-Channel MOSFET

### AO4568 (KO4568)

#### ■ Features

- $V_{DS} (V) = 30V$
- $I_D = 12 A (V_{GS} = 10V)$
- $R_{DS(ON)} < 11.5m\Omega (V_{GS} = 10V)$
- $R_{DS(ON)} < 17.5m\Omega (V_{GS} = 4.5V)$



#### ■ Absolute Maximum Ratings $T_a = 25^\circ C$

Parameter	Symbol	Rating	Unit
Drain-Source Voltage	$V_{DS}$	30	V
Gate-Source Voltage	$V_{GS}$	$\pm 20$	
V <sub>DS</sub> Spike	$V_{SPIKE}$	36	
Continuous Drain Current	$I_D$	12	A
		9.4	
Pulsed Drain Current	$I_{DM}$	48	
Avalanche Current	$I_{AS}$	13	
Avalanche Energy	$E_{AS}$	8	mJ
Power Dissipation	$P_D$	2.5	W
		1.6	
Thermal Resistance.Junction- to-Ambient	$R_{thJA}$	50	°C/W
		85	
Thermal Resistance.Junction- to-Lead	$R_{thJL}$	30	
Junction Temperature	$T_J$	150	°C
Storage Temperature Range	$T_{stg}$	-55 to 150	

## N-Channel MOSFET

### AO4568 (KO4568)

■ Electrical Characteristics Ta = 25°C

Parameter	Symbol	Test Conditions	Min	Typ	Max	Unit
Drain-Source Breakdown Voltage	V <sub>DSS</sub>	I <sub>D</sub> =250 μ A, V <sub>Gs</sub> =0V	30			V
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	V <sub>Ds</sub> =30V, V <sub>Gs</sub> =0V			1	uA
		V <sub>Ds</sub> =30V, V <sub>Gs</sub> =0V, T <sub>J</sub> =55°C			5	
Gate-Body Leakage Current	I <sub>GSS</sub>	V <sub>Ds</sub> =0V, V <sub>Gs</sub> =±20V			±100	nA
Gate Threshold Voltage	V <sub>Gs(th)</sub>	V <sub>Ds</sub> =V <sub>Gs</sub> , I <sub>D</sub> =250uA	1.4		2.2	V
Static Drain-Source On-Resistance	R <sub>Ds(on)</sub>	V <sub>Gs</sub> =10V, I <sub>D</sub> =12A			11.5	m Ω
		V <sub>Gs</sub> =10V, I <sub>D</sub> =12A T <sub>J</sub> =125°C			16.5	
		V <sub>Gs</sub> =4.5V, I <sub>D</sub> =10A			17.5	
Forward Transconductance	g <sub>FS</sub>	V <sub>Ds</sub> =5V, I <sub>D</sub> =12A		40		S
Input Capacitance	C <sub>iss</sub>	V <sub>Gs</sub> =0V, V <sub>Ds</sub> =15V, f=1MHz		600		pF
Output Capacitance	C <sub>oss</sub>			230		
Reverse Transfer Capacitance	C <sub>rss</sub>			30		
Gate Resistance	R <sub>g</sub>	V <sub>Gs</sub> =0V, V <sub>Ds</sub> =0V, f=1MHz	0.7		2.3	Ω
Total Gate Charge (10V)	Q <sub>g</sub>	V <sub>Gs</sub> =10V, V <sub>Ds</sub> =15V, I <sub>D</sub> =12A			9	nC
Total Gate Charge (4.5V)					4.4	
Gate Source Charge	Q <sub>gs</sub>	V <sub>Gs</sub> =10V, V <sub>Ds</sub> =15V, I <sub>D</sub> =12A			1.4	
Gate Drain Charge	Q <sub>gd</sub>				1.9	
Turn-On DelayTime	t <sub>d(on)</sub>	V <sub>Gs</sub> =10V, V <sub>Ds</sub> =15V, R <sub>L</sub> =1.25Ω, R <sub>GEN</sub> =3Ω			5	ns
Turn-On Rise Time	t <sub>r</sub>				2.5	
Turn-Off DelayTime	t <sub>d(off)</sub>				17.5	
Turn-Off Fall Time	t <sub>f</sub>				2.5	
Body Diode Reverse Recovery Time	t <sub>rr</sub>	I <sub>F</sub> = 12A, dI/dt= 500A/us			8.6	nC
Body Diode Reverse Recovery Charge	Q <sub>rr</sub>				10.5	
Maximum Body-Diode Continuous Current	I <sub>s</sub>				3	A
Diode Forward Voltage	V <sub>SD</sub>	I <sub>s</sub> =1A, V <sub>Gs</sub> =0V			1	V

Note : The static characteristics in Figures 1 to 6 are obtained using <300 us pulses, duty cycle 0.5% max.

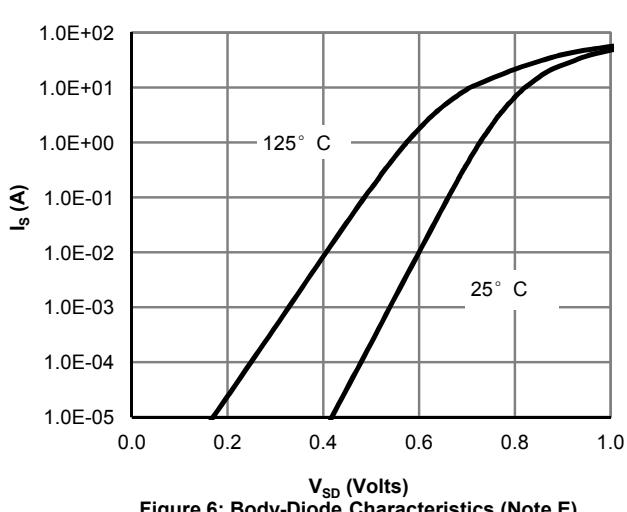
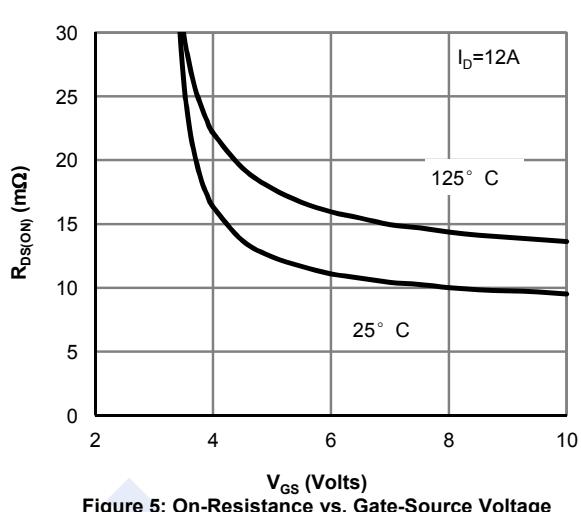
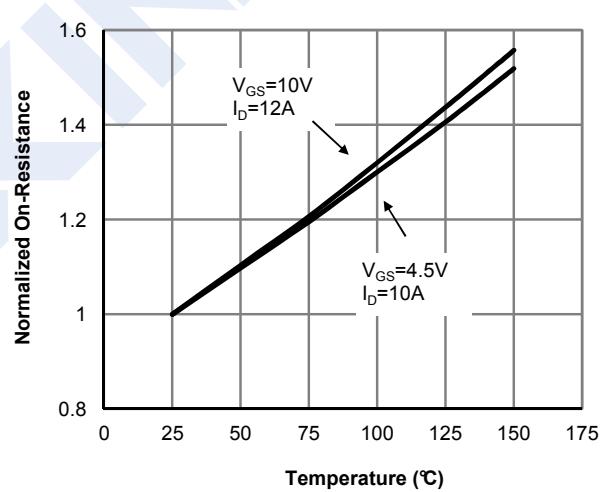
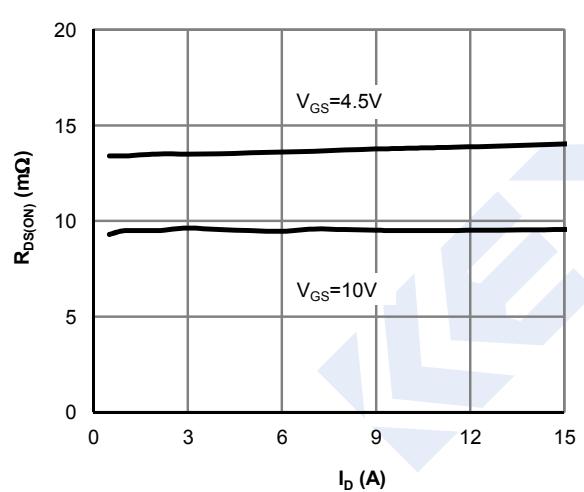
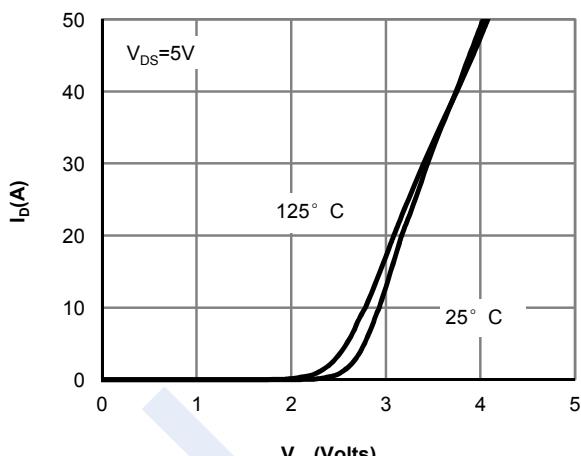
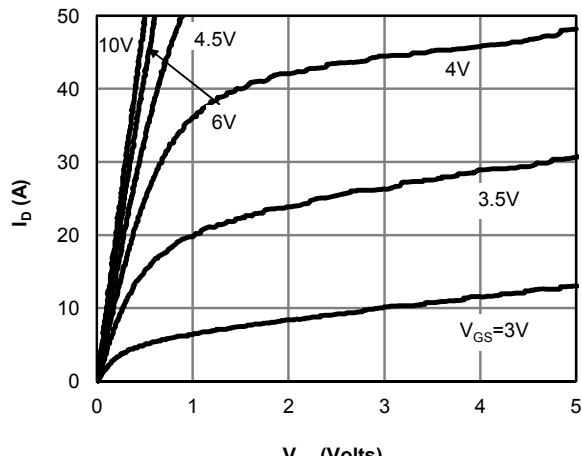
■ Marking

Marking	4568 KC****
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## N-Channel MOSFET

### AO4568 (KO4568)

#### ■ Typical Characteristics



## N-Channel MOSFET

AO4568 (KO4568)

## ■ Typical Characteristics

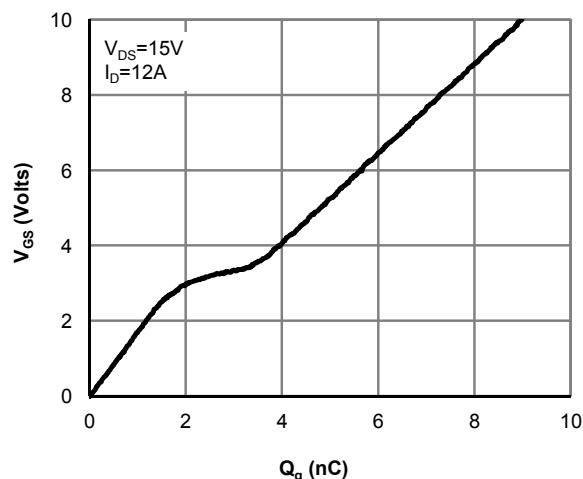


Figure 7: Gate-Charge Characteristics

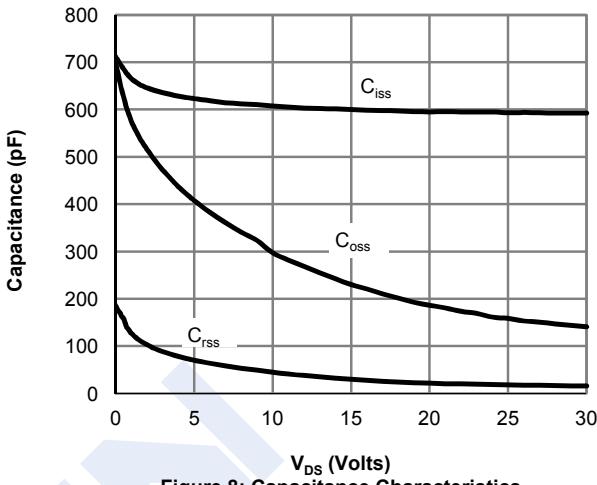


Figure 8: Capacitance Characteristics

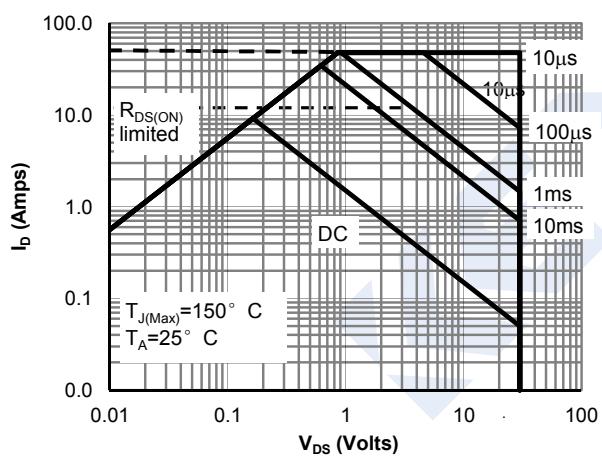


Figure 9: Maximum Forward Biased Safe Operating Area (Note F)

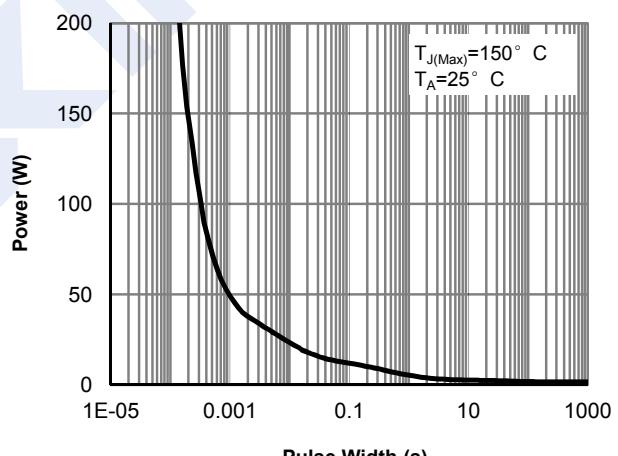


Figure 10: Single Pulse Power Rating Junction-to-Ambient (Note F)

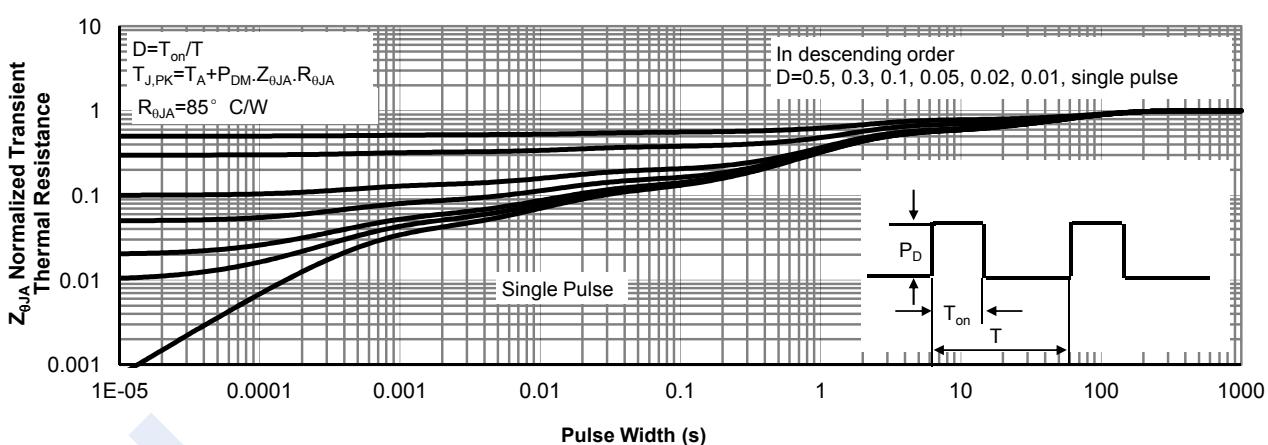


Figure 11: Normalized Maximum Transient Thermal Impedance (Note F)